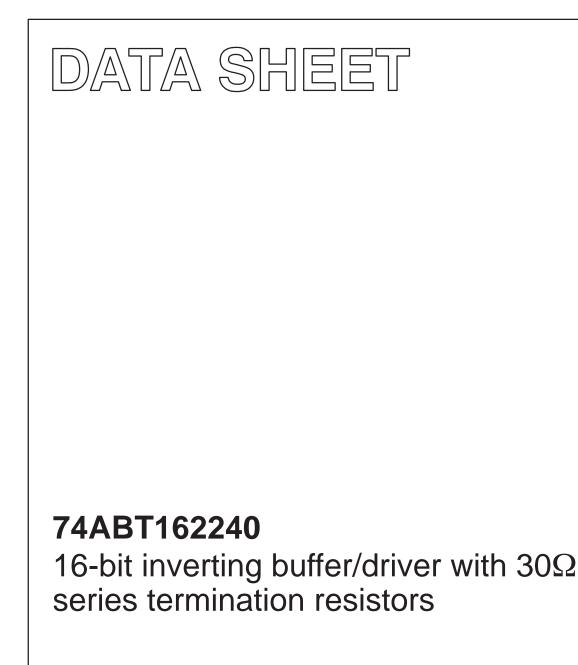
INTEGRATED CIRCUITS



Product data Supersedes data of 1998 Feb 25

2004 Feb 18



16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

FEATURES

- 16-bit bus interface
- 3-State buffers
- Output capability: +12mA/-32mA
- TTL input and output switching levels
- Live insertion/extraction permitted
- Power-up 3-State
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

QUICK REFERENCE DATA

DESCRIPTION

The 74ABT162240 is a high-performance BiCMOS device which combines low static and dynamic power dissipation with high speed.

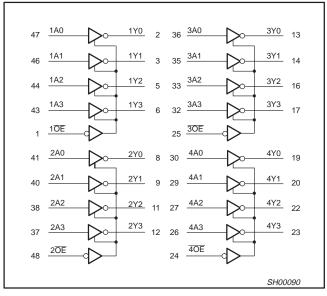
This device is an inverting 16-bit buffer that is ideal for driving bus lines. The device features four Output Enables $(1\overline{OE}, 2\overline{OE}, 3\overline{OE}, 4\overline{OE})$, each controlling four of the 3-State outputs.

SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25°C	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	C _L = 50pF; V _{CC} =	2.7 2.6	ns
C _{IN}	Input capacitance nOE	V _I = 0V or 3.0V	4	pF
C _{OUT}	Output capacitance	Outputs disabled; $V_0 = 0V$ or	6	pF
I _{CCZ}	Quiescent supply current	Outputs disabled; V _{CC} =	500	μΑ
I _{CCL}		Outputs low; $V_{CC} = 5.5V$	8	mA

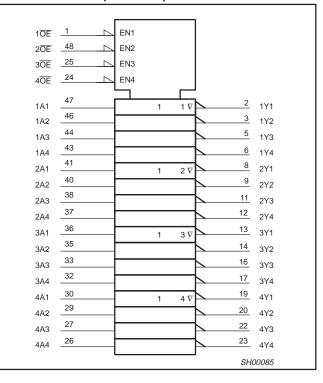
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	TYPE NUMBER	DWG NUMBER
48-Pin Plastic SSOP Type III	–40°C to +85°C	74ABT162240 DL	SOT370-1
48-Pin Plastic TSSOP Type II	–40°C to +85°C	74ABT162240 DGG	SOT362-1

LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



Product data

PIN CONFIGURATION

10E 1	48	2 0E
1Y0 2	47	1A0
1Y1 3	46	1A1
GND 4	45	GND
1Y2 5	44	1A2
1Y3 6	43	1A3
V _{CC} 7	42	V _{CC}
2Y0 8	41	2A0
2Y1 9	40	2A1
GND 10	39	GND
2Y2 11	38	2A2
2Y3 12	37	2A3
3Y0 13	36	3A0
3Y1 14	35	3A1
GND 15	34	GND
3Y2 16	33	3A2
3Y4 17	32	3A3
V _{CC} 18	31	V _{CC}
4Y0 19	30	4A0
4Y1 20	29	4A1
GND 21	28	GND
4Y2 22	27	4A2
4Y3 23	26	4A3
40E 24	25	3 0E
	SA00	2012
	SAU	1013

FUNCTION TABLE

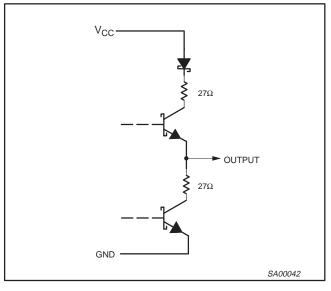
Inputs		Outputs
nOE	nAx	nYx
L	L	Н
L	Н	L
Н	Х	Z

H = High voltage level

L = Low voltage level

X = Don't care Z = High Impedance "off" state

SCHEMATIC OF Y OUTPUTS



PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 46, 44, 43, 41, 40, 38, 37, 36, 35, 33, 32, 30, 29, 27, 26	1A0-1A3 2A0-2A3 3A0-3A3 4A0-4A3	Data inputs
2, 3, 5, 6, 8, 9, 11, 12, 13, 14, 16, 17, 19, 20, 22, 23	170-173 270-273 370-373 470-473	Data outputs
1, 48, 25, 24	1 <u>0E,</u> 2 <u>0E,</u> 3 <u>0E,</u> 4 <u>0E</u>	Output enables
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V _{CC}	Positive supply voltage

74ABT162240

ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +7.0	V
I _{IK}	DC input diode current	V ₁ < 0	-18	mA
VI	DC input voltage ³		-1.2 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +5.5	V
leu-	DC output current Outp	Output in Low state	128	mA
OUT		Output in High state	-64	
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

 Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	ITS	UNIT
STWBUL	PARAMETER	MIN	MAX	
V _{CC}	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V _{CC}	V
V _{IH}	High-level input voltage	2.0		V
V _{IL}	Input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
I _{OL}	Low-level output current		32	mA
	Low-level output current; current duty cycle \leq 50%; f \geq 1kHz		12	
$\Delta t/\Delta v$	Input transition rise or fall rate; Outputs enabled	0	10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)

DC ELECTRICAL CHARACTERISTICS

					LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS		T _{amb} = +25°C			T _{amb} = −40°C to +85°C	
			Min	Тур	Max	Min	Max	
V _{IK}	Input clamp voltage	$V_{CC} = 4.5V; I_{IK} = -18mA$		-0.9	-1.2		-1.2	V
		V_{CC} = 4.5V; I_{OH} = -3mA; V_I = V_{IL} or V_{IH}	2.5	2.9		2.5		V
V _{OH}	High-level output voltage	V_{CC} = 5.0V; I_{OH} = -3mA; V_I = V_{IL} or V_{IH}	3.0	3.4		3.0		V
		V_{CC} = 4.5V; I_{OH} = -32mA; V_I = V_{IL} or V_{IH}	2.0	2.4		2.0		V
\/	Low-level output voltage	V_{CC} = 4.5V; I_{OL} = 8mA; V_I = V_{IL} or V_{IH}			0.65		0.65	V
V _{OL}	Low-level output voltage	V_{CC} = 4.5V; I_{OL} = 12mA; V_I = V_{IL} or V_{IH}			0.80		0.80	V
lı	Input leakage current	$V_{CC} = 5.5V; V_1 = GND \text{ or } 5.5V$		±0.01	±1.0		±1.0	μA
I _{OFF}	Power-off leakage current	V_{CC} = 0.0V; V_O or $V_I \le 4.5V$		±5.0	±100		±100	μA
I _{PU} /I _{PD}	Power-up/down 3-State output current	$V_{\underline{CC}} = 2.0V; V_{O} = 0.5V; V_{I} = GND \text{ or } V_{CC};$ $V_{OE} = V_{CC}$		±5.0	±50		±50	μA
I _{OZH}	3-State output High current	V_{CC} = 5.5V; V_{O} = 2.7V; V_{I} = V_{IL} or V_{IH}		1.0	10		10	μΑ
I _{OZL}	3-State output Low current	V_{CC} = 5.5V; V_{O} = 0.5V; V_{I} = V_{IL} or V_{IH}		-1.0	-10		-10	μA
I _{CEX}	Output high leakage current	V_{CC} = 5.5V; V_{O} = 5.5V; V_{I} = GND or V_{CC}		1.0	50		50	μA
Ι _Ο	Output current ¹	V _{CC} = 5.5V; V _O = 2.5V	-50	-70	-180	-50	-180	mA
I _{CCH}		V_{CC} = 5.5V; Outputs High, V_I = GND or V_{CC}		0.5	1.0		1.0	mA
I _{CCL}	Quiescent supply current	V_{CC} = 5.5V; Outputs Low, V_I = GND or V_{CC}		8	19		19	mA
I _{CCZ}	discount supply surrout	V_{CC} = 5.5V; Outputs 3-State; V ₁ = GND or V _{CC}		0.5	1.0		1.0	mA
ΔI_{CC}	Additional supply current per input pin ²	Outputs enabled, one input at 3.4V, other inputs at V _{CC} or GND; V _{CC} = $5.5V$		10	200		200	μΑ

NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

2. This is the increase in supply current for each input at 3.4V.

AC CHARACTERISTICS

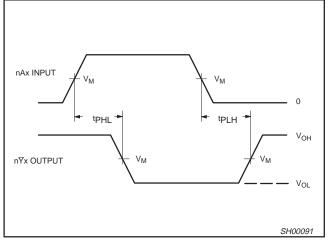
GND = 0V; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to $+85^{\circ}C$.

					LIMI	ſS		
SYMBOL	PARAMETER	WAVEFORM	T ₂ V	amb = +25° ′CC = +5.0′	C V	$T_{amb} = -40^{\circ}$ $V_{CC} = +5$	°C to +85°C .0V ±0.5V	UNIT
			Min	Тур	Мах	Min	Max	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	1.0 1.0	2.7 2.6	3.8 3.2	1.0 1.0	4.2 3.7	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.2 1.0	2.3 2.9	3.2 3.8	1.2 1.0	4.0 4.7	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.6 1.4	3.0 2.8	4.1 3.8	1.6 1.4	4.7 4.0	ns

AC WAVEFORMS

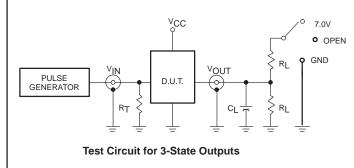
 V_{M} = 1.5V, V_{IN} = GND to 2.7V

16-bit inverting buffer/driver with 30Ω series termination resistors (3-State)



Waveform 1. Input (nAx) to Output (nYx) Propagation Delays

TEST CIRCUIT AND WAVEFORMS



SWITCH POSITION

TEST	SWITCH
t _{PLZ}	closed
t _{PZL}	7V
All other	open

DEFINITIONS

tw

V_M = 1.5V Input Pulse Definition

FAMILY	INPUT PULSE REQUIREMENTS						
FAMILY	Amplitude	Rep. Rate	t _W	t _R	t _F		
74ABT16	3.0V	1MHz	500ns	2.5ns	2.5ns		

R_L = Load resistor; see AC CHARACTERISTICS for value. Load capacitance includes jig and probe capacitance; $C_L =$ see AC CHARACTERISTICS for value.

Termination resistance should be equal to Z_{OUT} of R_T = pulse generators.

AMP (V)

AMP (V)

0V

0\/

t_{TLH} (t_R)

tTHL (tF)

90%

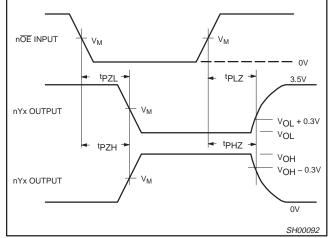
10%

V

10%

90%

٧N



Waveform 2. 3-State Output Enable and Disable Times

tw

90%

٧M

10%

90%

٧M

tTHL (tF)

tTLH (tR)

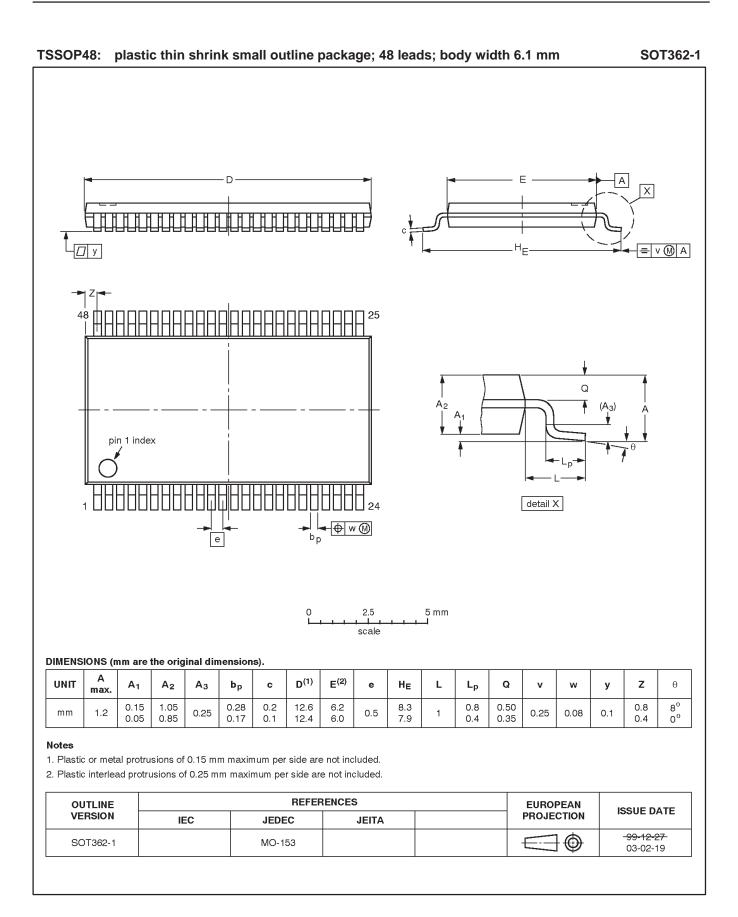
NEGATIVE PULSE

POSITIVE

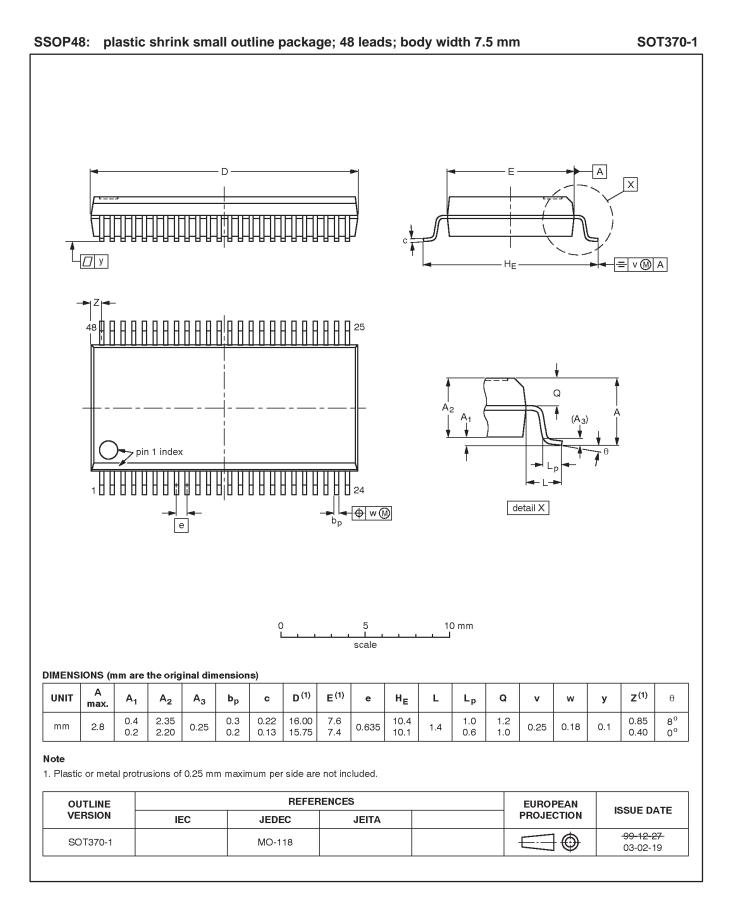
10%

PULSE

74ABT162240



74ABT162240



74ABT162240

REVISION HISTORY

Rev	Date	Description
_4	20040218	Product data (9397 750 12935); 853-1825 ECN 01-A15419 of 26 January 2004. Supersedes data sheet 74ABT_H162240_3 of 1998 Feb 25 (9397 750 03482).
		Modifications:
		 Delete all references to 74ABTH162240 (product discontinued).
_3	19980225	Product data (9397 750 03482); ECN 853-1825 19019 of 25 February 1998. Supersedes previous version.

Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Contact information

For additional information please visit http://www.semiconductors.philips.com. Fax:

sales.addresses@www.semiconductors.philips.com

For sales offices addresses send e-mail to:

Fax: +31 40 27 24825

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